


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/628,228	<b>Applicant(s)/Patent under Reexamination</b> TAKENAKA, HIDEKI
	<b>Examiner</b> ALEX LIEW	<b>Art Unit</b> 2624

ISSUE CLASSIFICATION												
ORIGINAL					INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS			CLAIMED					NON-CLAIMED		
382		118			G	6	K	9	/00		/	
CROSS REFERENCES									/		/	
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								/		/	
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Alex Liew 6/5/08 (Assistant Examiner) (Date)					/Matthew C Bella/ Supervisory Patent Examiner, Art Unit 2624 6/5/08					Total Claims Allowed: 15		
(Legal Instruments Examiner) (Date)					(Primary Examiner) (Date)					O.G. Print Claim(s) 1		O.G. Print Fig. 5

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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